

Based on Form PTO-1449 (3/90)				ATTY. DOCKET NO. 514413-3869, 1		SERIAL NO. 10/734,792	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT HACKER ET AL.			
				FILING DATE		GROUP 1617	

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	AA	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>SM</i>	AA	6,239,071	05/2001	Giencke			

FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>SM</i>	AB	WO 98/15537	04/16/98	WIPO	/	/		
<i>SM</i>	AC	WO 98/34925	08/13/98	WIPO				
<i>SM</i>	AD	0 471 284 A1	02/19/92	EUROPE				
<i>SM</i>	AE	0 471 221 A1	02/19/92	EUROPE				
<i>SM</i>	AF	0 469 406 A1	02/05/92	EUROPE				
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<i>SM</i>	AI	0 810 219 A1	12/03/97	EUROPE				

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)		
<i>SM</i>	AJ	Patent Abstracts of Japan, vol. 16, no. 329, Publication Number 04095003, Publication Date March 27, 1992
<i>SM</i>	AK	Derwent Publication, Japanese application no. 1995-397094, referred to as XP-002125908
<i>SM</i>	AL	Derwent Publication, Japanese application no. 1995-397095, referred to as XP-002125909

EXAMINER <i>J. Mark O'Neil</i>	DATE CONSIDERED 3/10/2006
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.